

Specification	AXM55310-16	Issue: 02	Date: 2009-09-22
Oscillator type : MIL-grade Packaged Crystal Oscillator (PXO)			
In accordance with MIL-PRF-55310/16H			

Parameter	min.	typ.	max.	Unit	Condition
Frequency range	0.150		80.000	MHz	
Frequency stability				ppm	
Initial accuracy	See table 1			ppm	@ 23°C
vs. temperature in operating temperature range	± 25 ~ ± 100			ppm	See table 1
Operating temperature range	-55		+125	°C	Range A
	-55		+105	°C	Range B
	-20		+70	°C	Range C
vs. supply voltage variation			±2	ppm	V _{CC} ±10%
vs. load change				ppm	
long term (aging) after 30 days @70°C			±5~±10	ppm/year	See table 1
Frequency adjustment range					
Electronic Frequency Control (EFC) range @ 25°C	N.A.				
RF output					
Signal waveform	TTL compatible				
Load	6 ~ 10 TTL				See table 1
Rise & decay time			5 ~ 15	ns	See table 1
Symmetry (duty cycle)	40~45		55~60	%	See table 1
Supply voltage V_{CC}	4.5	5.0	5.5	V	
Current consumption (steady state)			30~70	mA	See table 1
Storage temperature range	-62		+125	°C	
Enclosure (see drawing) (L x W x H)	20.7x13.1x5.08 max.			mm	IEC 60679-3 CO-04
Weight			10	gram	
Marking	Part number Frequency Date Code Serial number				Note 3
Packing	Palette or sticks				IEC 60286-3
Product Screening Level (Note 2)	B				MIL-PRF-55310, Tbl II
Handling and Testing	In accordance with AXAN-011				www.axtal.com
Processing	In accordance with AXAN-012				www.axtal.com

Notes:

- Terminology and test conditions are according to MIL-PRF55310 and IEC standard IEC60679-1, unless otherwise stated
- Screening Level B includes 100 % electrical test, leak test, thermal cycling (-55°/+85°, 5 cycles), burn-in (160h @125°C), frequency stability vs. temperature.
Other product screening levels on request
- Date Code format wwAXyy with ww = calendar week, yy = year

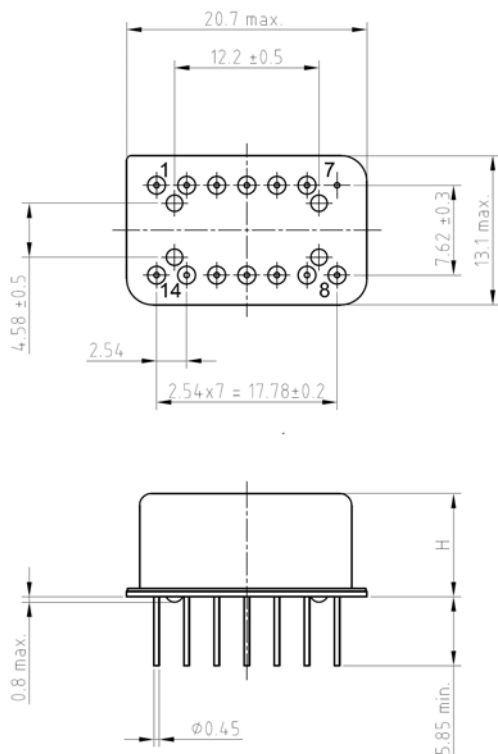
Part Number Ordering Code:

Model	Product Screening Level	Dash number*	Operating temperature range (A, B, or C)*	Frequency (M = MHz, k = kHz)
AXM55310-16	B	41	A	12M0000

* see table 1

Example: AXM55310-16-B-41A-12M0000

Enclosure drawing



Pin connections

Pin #	Symbol	Function
1 to 6	N.C.	No Connection
7	GND	Ground
8	RF OUT	RF Output
9 to 13	N.C.	No Connection
14	V _{CC}	Supply Voltage

Note:

All pins with N.C. function may be connected internally and are not to be used as external connections

Dash number	Output frequency range	Input current max at 5.25 V ±1% 1/	Pulse characteristics			Initial accuracy ppm at +23°C ±1°C	Frequency aging ppm/year after 30 days	Frequency-temperature tolerance (ppm)		
			Rise and fall times max	Duty cycle at 1.4 V	Load max 2/			-55°C to +125°C	-55°C to +105°C	-20°C to +70°C
								A	B	C
01	0.1 Hz to 250 Hz	mA 158	ns 15	percent 45 to 55	10 TTL	±15	±5	±50	±40	±25
04	0.1 Hz to 250 Hz	158	15	45 to 55	10 TTL	±25	±10	±100	±80	±50
11	250 Hz to 150 kHz	94	15	45 to 55	10 TTL	±15	±5	±50	±40	±25
14	250 Hz to 150 kHz	94	15	45 to 55	10 TTL	±25	±10	±100	±80	±50
21	150 kHz to 5 MHz	70	15	45 to 55	10 TTL	±15	±5	±50	±40	±25
24	150 kHz to 5 MHz	70	15	45 to 55	10 TTL	±25	±10	±100	±80	±50
31	4 MHz to 20 MHz	30	15	40 to 60	10 TTL	±15	±5	±50	±40	±25
34	4 MHz to 20 MHz	30	15	40 to 60	10 TTL	±25	±10	±100	±80	±50
41	20 MHz to 80 MHz	65	5	40 to 60	6 TTL	±15	±5	±50	±40	±25
44	20 MHz to 80 MHz	65	5	40 to 60	6 TTL	±25	±10	±100	±80	±50

Table 1: Dash numbers and operating characteristics

Mechanical and environmental conditions

Test	MIL-STD-202G Method	MIL-PRF-55310D Clause	Test conditions
Sealing tests	112E	3.6.1.2	Gross leak: Test Qc, Fine leak: Test Qk
Terminal strength	211		Test condition C
Solderability	208H	3.6.52	(235 ± 5)°C Method 1
Shock	213B	3.6.40	3 x per axes 100g, 6 ms half-sine pulse, non-operating
Vibration, sinusoidal	204D	3.6.38.1	Test condition D, non-operating
Endurance tests (ageing)	108A	4.8.35	30 days @ 70°C

Other environmental conditions on request